

IGBT

SGP6N60UFD

Ultra-Fast IGBT

General Description

Fairchild's Insulated Gate Bipolar Transistor(IGBT) UFD series provides low conduction and switching losses. UFD series is designed for the applications such as motor control and general inverters where High Speed Switching is required.

Features

- High Speed Switching
- Low Saturation Voltage : $V_{CE(sat)} = 2.1 \text{ V } @ I_C = 3A$
- High Input Impedance
- CO-PAK, IGBT with FRD : t_{rr} = 35ns (typ.)

Application

AC & DC Motor controls, General Purpose Inverters, Robotics, Servo Controls





Absolute Maximum Ratings T_C = 25°C unless otherwise noted

Symbol	Description		SGP6N60UFD	Units
V _{CES}	Collector-Emitter Voltage		600	V
V_{GES}	Gate-Emitter Voltage		± 20	V
	Collector Current	@ T _C = 25°C	6	Α
I _C	Collector Current	@ T _C = 100°C	3	Α
I _{CM (1)}	Pulsed Collector Current		25	Α
I _F	Diode Continuous Forward Current	@ T _C = 100°C	4	Α
I _{FM}	Diode Maximum Forward Current		25	Α
P_{D}	Maximum Power Dissipation	@ T _C = 25°C	30	W
	Maximum Power Dissipation	@ T _C = 100°C	12	W
T _J	Operating Junction Temperature		-55 to +150	°C
T _{stg}	Storage Temperature Range		-55 to +150	°C
T _L	Maximum Lead Temp. for Soldering Purposes, 1/8" from Case for 5 Seconds		300	°C

Notes :

(1) Repetitive rating : Pulse width limited by max. junction temperature

Thermal Characteristics

Symbol	Parameter	Тур.	Max.	Units
$R_{\theta JC}(IGBT)$	Thermal Resistance, Junction-to-Case		4.0	°C/W
$R_{\theta JC}(DIODE)$	Thermal Resistance, Junction-to-Case		7.0	°C/W
R _{A,IA}	Thermal Resistance, Junction-to-Ambient		62.5	°C/W

	Parameter	Test Conditions	Min.	Тур.	Max.	Units
Off Char	racteristics					
BV _{CES}	Collector-Emitter Breakdown Voltage	$V_{GE} = 0V, I_{C} = 250uA$	600			V
ΔB _{VCES} / ΔT _J	Temperature Coeff. of Breakdown Voltage	V _{GE} = 0V, I _C = 1mA		0.6		V/°C
I _{CES}	Collector Cut-Off Current	$V_{CE} = V_{CES}, V_{GE} = 0V$			250	uA
I_{GES}	G-E Leakage Current	$V_{GE} = V_{GES}, V_{CE} = 0V$			± 100	nΑ
On Char	acteristics					
V _{GE(th)}	G-E Threshold Voltage	$I_C = 3mA$, $V_{CF} = V_{GF}$	3.5	4.5	6.5	V
	Collector to Emitter	$I_C = 3A$, $V_{GE} = 15V$		2.1	2.6	V
$V_{CE(sat)}$	Saturation Voltage	$I_C = 6A$, $V_{GE} = 15V$		2.6		V
Dynamic C _{ies}	Characteristics Input Capacitance			220		pF
	Output Capacitance	$V_{CE} = 30V_{.} V_{GE} = 0V,$		220		pF
C _{oes}	Reverse Transfer Capacitance	f = 1MHz		7		ρΓ PF
Switchir	ng Characteristics Turn-On Delay Time			15		ns
t _r	Rise Time			25		ns
t _{d(off)}	Turn-Off Delay Time	$V_{CC} = 300 \text{ V}, I_{C} = 3\text{A},$		60	130	ns
t _f	Fall Time	$R_G = 80\Omega$, $V_{GE} = 15V$,		70	150	ns
E _{on}	Turn-On Switching Loss	Inductive Load, T _C = 25°C		57		uJ
E _{off}	Turn-Off Switching Loss			25		uJ
⊢off						uJ
	Total Switching Loss	_		82	120	
E _{ts}	Total Switching Loss Turn-On Delay Time					uJ
E _{ts}				82	120	uJ uJ
E _{ts} t _{d(on)} t _r	Turn-On Delay Time Rise Time Turn-Off Delay Time	V _{CC} = 300 V, I _C = 3A,		82 22 32 80	120	uJ uJ ns
$\begin{aligned} & E_{ts} \\ & t_{d(on)} \\ & t_r \\ & t_{d(off)} \\ & t_f \end{aligned}$	Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time	$R_G = 80\Omega$, $V_{GE} = 15V$,	 	82 22 32 80 122	120 200 300	uJ uJ ns ns ns
$\begin{array}{c} E_{ts} \\ t_{d(on)} \\ t_{r} \\ \\ t_{d(off)} \\ \\ t_{f} \\ \\ E_{on} \end{array}$	Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time Turn- On Switching Loss		 	82 22 32 80 122 65	120 200 300 	uJ uJ ns ns ns ns
$\begin{aligned} & E_{ts} \\ & t_{d(on)} \\ & t_r \\ & t_{d(off)} \\ & t_f \\ & E_{on} \\ & E_{off} \end{aligned}$	Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time Turn- On Switching Loss Turn- Off Switching Loss	$R_G = 80\Omega$, $V_{GE} = 15V$,	 	82 22 32 80 122 65 46	120 200 300 	uJ uJ ns ns ns ns uJ
$\begin{array}{c} E_{ts} \\ \hline t_{d(on)} \\ t_r \\ \hline t_{d(off)} \\ \hline t_f \\ E_{on} \\ E_{off} \\ E_{ts} \\ \end{array}$	Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time Turn- On Switching Loss Turn- Off Switching Loss Total Switching Loss	$R_G = 80\Omega$, $V_{GE} = 15V$,	 	82 22 32 80 122 65 46 111	120 200 300 170	uJ uJ ns ns ns ns uJ uJ
$\begin{array}{c} E_{ts} \\ \hline t_{d(on)} \\ \hline t_r \\ \hline t_{d(off)} \\ \hline t_f \\ \hline E_{on} \\ \hline E_{off} \\ \hline E_{ts} \\ \hline Q_{q} \\ \end{array}$	Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time Turn- On Switching Loss Turn- Off Switching Loss Total Switching Loss Total Gate Charge	$R_G = 80\Omega$, $V_{GE} = 15V$, Inductive Load, $T_C = 125^{\circ}C$	 	82 22 32 80 122 65 46 111	120 200 300 170 22	uJ uJ ns ns ns uJ uJ uJ uJ uC
	Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time Turn- On Switching Loss Turn- Off Switching Loss Total Switching Loss	$R_G = 80\Omega$, $V_{GE} = 15V$,	 	82 22 32 80 122 65 46 111	120 200 300 170	uJ uJ ns ns ns ns uJ uJ

Electrical Characteristics of DIODE $T_C = 25^{\circ}C$ unless otherwise noted

Symbol	Parameter	Test Conditions		Min.	Тур.	Max.	Units
V _{FM}	Diode Forward Voltage	I _F = 4A	$T_C = 25^{\circ}C$		1.4	1.7	V
			T _C = 100°C		1.3		
+	Diode Reverse Recovery Time		$T_C = 25^{\circ}C$		35	52	nc
t _{rr}			T _C = 100°C		53		ns
1	Diode Peak Reverse Recovery	di/dt = 200A/us T ₀	$T_C = 25^{\circ}C$		3.5	5.0	Α
¹ rr	Current		T _C = 100°C		4.5		
Q _{rr}	Diode Reverse Recovery Charge		$T_C = 25^{\circ}C$		60	135	nC
			T _C = 100°C		120		110

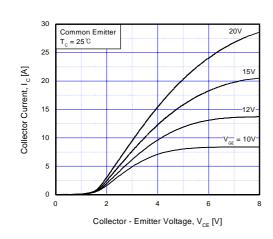


Fig 1. Typical Output Characteristics

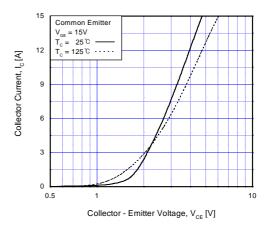


Fig 2. Typical Saturation Voltage Characteristics

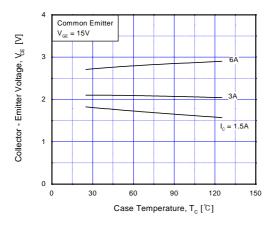


Fig 3. Saturation Voltage vs. Case
Temperature at Variant Current Level

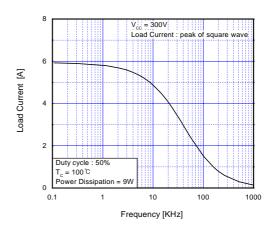


Fig 4. Load Current vs. Frequency

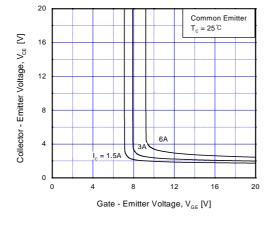


Fig 5. Saturation Voltage vs. V_{GE}

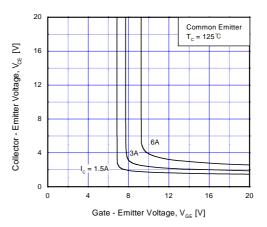
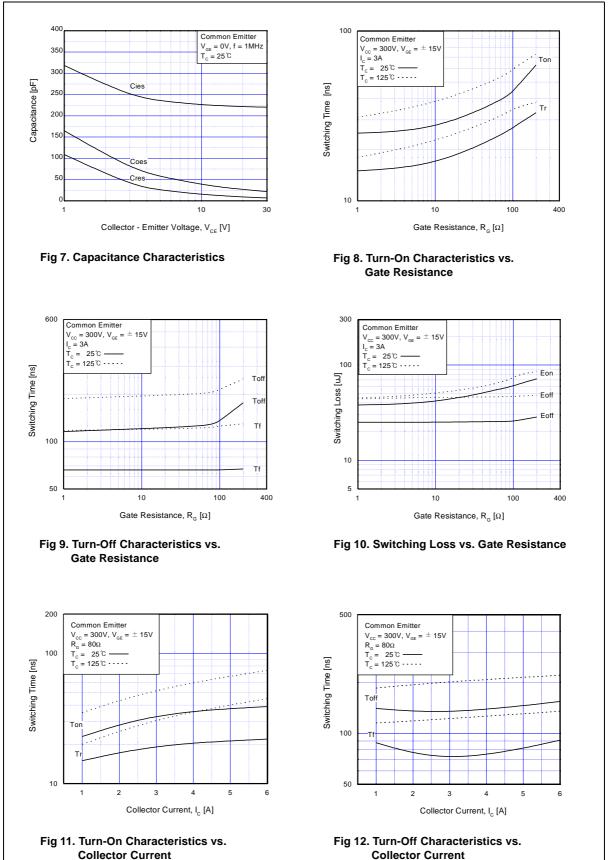


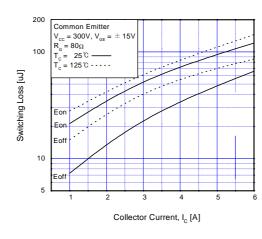
Fig 6. Saturation Voltage vs. V_{GE}

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Collector Current



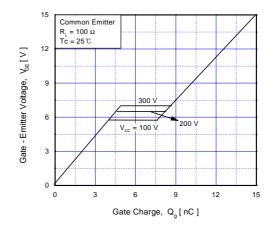
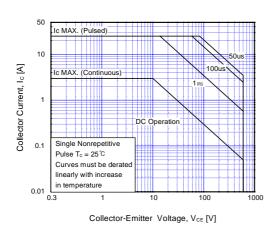


Fig 13. Switching Loss vs. Collector Current

Fig 14. Gate Charge Characteristics



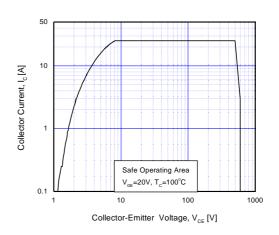


Fig 15. SOA Characteristics

Fig 16. Turn-Off SOA Characteristics

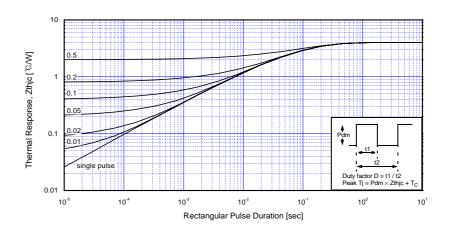


Fig 17. Transient Thermal Impedance of IGBT

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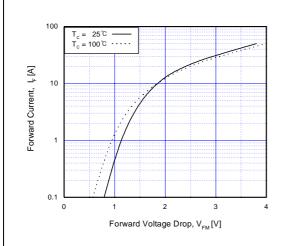
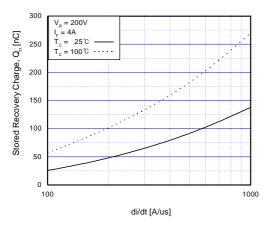


Fig 18. Forward Characteristics

Fig 19. Reverse Recovery Current



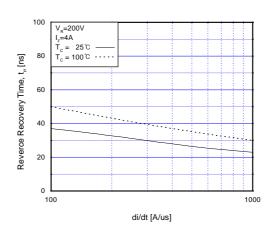


Fig 20. Stored Charge

Fig 21. Reverse Recovery Time

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